Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/750,580	HIGASHI ET AL.	
Examiner	Art Unit	
Thinh T. Nguyen	2818	

SEARCHED			
Class	Subclass	Date	Examiner
257	777	12/5/2005	TTN
257	437	12/5/2005	TTN
257	433	12/6/2005	TTN
257	739	12/6/2005	TTN
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INTERFERENCE SEARCHED .			
Class	Subclass	Date	Examiner
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EAST	PUB	5/30/07	TIN

SEARCH NO (INCLUDING SEARCH)	
	DATE	EXMR	
EAST	12/5/2005	TTN	
EAST _.	12/6/2005	TTN	
EAST	4(4/07	TN.	
EAST	5/30/07	-177	
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